4-Bit Dual-Supply Non-Inverting Level Translator

The NLSV4T3144 is a 4-bit configurable dual-supply bus buffer level translator. The input (IN_x_n) and output (OUT_x_n) ports are designed to track two different power supply rails, $V_{\rm CCA}$ and $V_{\rm CCB}$ respectively. Both supply rails are configurable from 1.6 V to 3.6 V allowing low-voltage translation from the input to the output port.

Features

- Wide V_{CCA} and V_{CCB} Operating Range: 1.6 V to 3.6 V
- High-Speed w/ Balanced Propagation Delay
- Inputs and Outputs have OVT Protection to 5.5 V
- Outputs at 3-State until Active V_{CCA} and V_{CCB} are Reached
- Power-Off Protection
- Ultra-Small Packaging: 1.7 mm x 2.0 mm UQFN-12
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

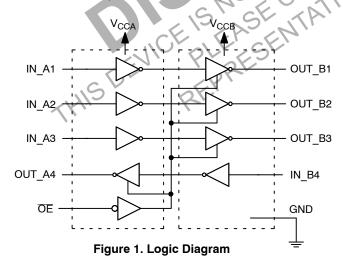
Typical Applications

- Mobile Phones, PDAs, Other Portable Devices
- SPI™ Bus Voltage Translation

Important Information

• ESD Protection for All Pins:

HBM (Human Body Model) > 3000 V





ON Semiconductor®

www.onsemi.com



UQFN12 MU SUFFIX CASE 523AE

MARKING DIAGRAM

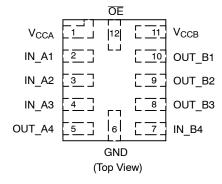


WG = Specific Device Code
M = Date Code

Pb-Free Package

(Note: Microdot may be in either location)

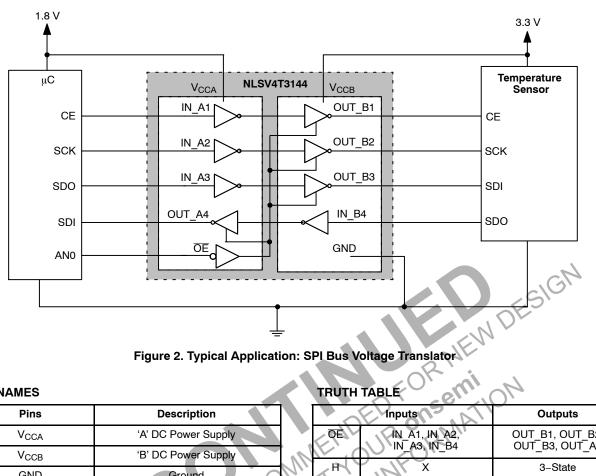
PIN ASSIGNMENTS



ORDERING INFORMATION

Device	Package	Shipping [†]
NLSV4T3144MUTAG	UQFN-12 (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.



PIN NAMES

Pins	Description
V _{CCA}	'A' DC Power Supply
V _{CCB}	'B' DC Power Supply
GND	Ground
IN_A1, IN_A2, IN_A3	Input (Referenced to V _{CCA})
IN_B4	Input (Referenced to V _{CCB})
OUT_B1, OUT_B2, OUT_B3	Output (Referenced to V _{CCB})
OUT_A4	Output (Referenced to V _{CCA})
OEC	Output Enable (Referenced to V_{CCA})

TO E	Inputs	Outputs
ŌĒ	IN_A1, IN_A2, IN_A3, IN_B4	OUT_B1, OUT_B2, OUT_B3, OUT_A4
A BY	W X	3-State
L	L	L
FO-	Н	Н

MAXIMUM RATINGS

Symbol	Parameter	Value	Condition	Unit
V _{CCA} , V _{CCB}	DC Supply Voltage, V _{CCA} ≤ V _{CCB}	-0.5 to +5.5		V
VI	DC Input Voltage IN_x _n	-0.5 to +5.5		V
V _C	Control Input OE	-0.5 to +5.5		V
Vo	DC Output Voltage (Power Down) OUT_x _n	-0.5 to +5.5	V _{CCA} = V _{CCB} = 0	V
	(Active Mode) OUT_x _n	-0.5 to +5.5		
	(Tri-State Mode) OUT_x _n	-0.5 to +5.5		
I _{IK}	DC Input Diode Current	-20	V _I < GND	mA
I _{OK}	DC Output Diode Current	-50	V _O < GND	mA
Io	DC Output Source/Sink Current	±50		mA
I _{CCA} , I _{CCB}	DC Supply Current Per Supply Pin	±100		mA
I _{GND}	DC Ground Current per Ground Pin	±100	(2)	mA
T _{STG}	Storage Temperature	-65 to +150	CIQ!	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V _{CCA} , V _{CCB}	Positive DC Supply Voltage, V _{CCA} ≤ V _{CCB}	1.6	3.6	V
VI	Bus Input Voltage	GND	3.6	V
V _C	Control Input	GND	3.6	V
V _{IO}	DC Output Voltage (Power Down) OUT_xn	GND	3.6	V
	(Active Mode) OUT_x _n	71		
	(Tri-State Mode) OUT_x _n			
T _A	Operating Temperature Range	-40	+85	°C
Δt / ΔV	Input Transition Rise or Rate V _I , from 30% to 70% of V _{CCA} and V _{CCB} ; V _{CCA} = V _{CCB} = 3.3 V \pm 0.3 V	0	10	ns
THIS	DEVICE PLEESEN			1

DC ELECTRICAL CHARACTERISTICS

					-40°C to	+ 85°C	
Symbol	Parameter	Test Conditions	V _{CCA} (V)	V _{CCB} (V)	Min	Max	Unit
V _{IH}	Input HIGH Voltage		2.7 – 3.6	≥V _{CCA}	2.0	-	V
(IN_A1, IN_A2,			2.3 – 2.7		1.6	-	
IN_A2, IN_A3, OE)			1.6 –2.3		0.65 * V _{CCA}	-	
V _{IH}	Input HIGH Voltage		≤ V _{CCB}	2.7 – 3.6	2.0	-	V
(IN_B4)				2.3 – 2.7	1.6	-	
				1.6 –2.3	0.65 * V _{CCB}	-	
V_{IL}	Input LOW Voltage		2.7 - 3.6	≥V _{CCA}	-	0.8	V
(IN_A1, IN_A2,			2.3 - 2.7		-	0.7	
N_A3, OE)			1.6 –2.3		-	0.35 * V _{CCA}	
V_{IL}	Input LOW Voltage		≤ V _{CCB}	2.7 – 3.6	i	0.8	٧
(IN_B4)				2.3 – 2.7		0.7	
				1.6 –2.3		0.35 * V _{CCB}	
V_{OH}	Output HIGH Voltage	$I_{OH} = -100~\mu\text{A};~V_I = V_{IH}$	≤ V _{CCB}	1.6 – 3.6	V _{CCB} - 0.2	-	٧
(OUT_B1, OUT_B2,		$I_{OH} = -6 \text{ mA}; V_I = V_{IH}$	1.6	1.6	1.25	-	
OUT_B3)			2.3	2.3	2.0	-	
		$I_{OH} = -12 \text{ mA}; V_I = V_{IH}$	2.3	2.3	1.8	-	
			2.7	2.7	2.2	-	
		$I_{OH} = -18 \text{ mA}; V_I = V_{IH}$	2.3	2.3	1.7	-	
			3.0	3.0	2.4	-	
		$I_{OH} = -24 \text{ mA}; V_l = V_{IH}$	3.0	3.0	2.2	-	
V _{OH}	Output HIGH Voltage	$I_{OH} = -100 \mu A; V_I = V_{IH}$	1.6 – 3.6	≥ V _{CCA}	V _{CCA} - 0.2	-	٧
(OUT_A4)		$I_{OH} = -6 \text{ mA}; V_I = V_{IH}$	1.6	1.6	1.25	-	
		J 25 17 1	2.3	2.3	2.0	-	_
		$I_{OH} = -12 \text{ mA; } V_I = V_{IH}$	2.3	2.3	1.8	-	
		400011	2.7	2.7	2.2	-	
		$I_{OH} = -18 \text{ mA}; V_I = V_{IH}$	2.3	2.3	1.7	-	_
	EVICEP	E CEI	3.0	3.0	2.4	-	
	EN, A	$I_{OH} = -24 \text{ mA}; V_I = V_{IH}$	3.0	3.0	2.2	-	
V _{OL}	Output LOW Voltage	$I_{OL} = 100 \mu A; V_I = V_{IH}$	≤ V _{CCB}	1.6 – 3.6	-	0.2	٧
(OUT_B1, OUT_B2,	12 Br	$I_{OL} = 6 \text{ mA}; V_I = V_{IH}$	1.6	1.6	_	0.3	_
OUT_B3)		I_{OL} = 12 mA; $V_I = V_{IH}$	2.3	2.3	-	0.4	
			2.7	2.7	-	0.4	
		I_{OL} = 18 mA; $V_I = V_{IH}$	2.3	2.3	-	0.6	
			3.0	3.0	-	0.5	
		I_{OL} = 24 mA; V_I = V_{IH}	3.0	3.0	-	0.6	
V _{OL}	Output LOW Voltage	I_{OL} = 100 μ A; V_I = V_{IH}	1.6 – 3.6	≥V _{CCA}	-	0.2	٧
(OUT_A4)		$I_{OL} = 6 \text{ mA}; V_I = V_{IH}$	1.6	1.6	-	0.3	
		I_{OL} = 12 mA; V_I = V_{IH}	2.3	2.3	-	0.4	
			2.7	2.7	-	0.4	
		I_{OL} = 18 mA; V_I = V_{IH}	2.3	2.3	-	0.6	
			3.0	3.0	_	0.5]
		I_{OL} = 24 mA; V_I = V_{IH}	3.0	3.0	_	0.6	

DC ELECTRICAL CHARACTERISTICS

					-40°C to	+ 85°C	
Symbol	Parameter	Test Conditions	V _{CCA} (V)	V _{CCB} (V)	Min	Max	Unit
I _{IN}	Input Leakage Current	$V_{IN_A1} = V_{IN_A2} = V_{IN_A3} = V_{CCA}$ or GND; $V_{IN_B4} = V_{CCB}$ or GND	≤ V _{CCB}	1.6 – 3.6	-1.0	+1.0	μΑ
I _{OZ}	I/O Tri – State Output Leakage Current	TA = 25° C, $\overline{OE} = V_{CCA}$	≤ V _{CCB}	1.6 – 3.6	-	1.0	μΑ
I _{CCA}	Quiescent Supply Current	$V_{IN_A1} = V_{IN_A2} = V_{IN_A3} = V_{CCA}$ or GND; $V_{IN_B4} = V_{CCB}$ or GND $\overline{OE} = \text{GND}$, $I_O = 0$	≤V _{CCB}	1.6 – 3.6	-	3.0	μΑ
ІССВ	Quiescent Supply Current	$V_{IN_A1} = V_{IN_A2} = V_{IN_A3} = V_{CCA}$ or GND; $V_{IN_B4} = V_{CCB}$ or GND $\overline{OE} = \text{GND}$, $I_O = 0$	≤V _{CCB}	1.6 – 3.6	-	3.0	μΑ
I _{CCA} + I _{CCB}	Quiescent Supply Current	$\begin{aligned} &V_{IN_A1} = V_{IN_A2} = & V_{IN_A3} = \\ &V_{CCA} \text{ or GND;} \\ &V_{IN_B4} = &V_{CCB} \text{ or GND} \\ &\overline{OE} = & \text{GND, } I_O = 0 \end{aligned}$	≤V _{CCB}	1.6 – 3.6	NOF	6.0	μΑ

NOTE: Connect ground before applying supply voltage V_{CCA} or V_{CCB}. This device is designed with the feature that the power-up sequence of V_{CCA} and V_{CCB} will not damage the IC.

AC ELECTRICAL CHARACTERISTICS

				0,0		o +85°C _B (V)),		
		NE!	3.	.6	2	\ 1	1	.6	
Symbol	Parameter	V _{CCA} (V)	Min	Max	Min	Max	Min	Max	Unit
t _{PLH} , t _{PHL}	Propagation	3.6	-0	3					ns
	Delay,	2.8	O,	3.1		3.3			1
	Input to Output	1.6		4.3		4.5		6.1	1
t _{PZH} , t _{PZL}	Output Enable,	3.6		8.7					ns
	OE to Output	2.8		10.3		10.7			
	IICE SEIGE	1.6		17.2		18		20	
t _{PHZ} , t _{PLZ}	Output	3.6		7.8					ns
	Disable,	2.8		8.2		8.4			
< \	OE to Output	1.6		9.5		9.8		10.5	
t _{OSHL} ,	Output to Output Skew	3.6		0.25					ns
toslh		2.8		0.25		0.25			
		1.6		0.25		0.25		0.25	

NOTE: Propagation delays defined per Figure 3.

CAPACITANCE

Symbol	Parameter	Test Conditions	Typ (Note 1)	Unit
Cl	Control Pin (OE) Input Capacitance	$V_{CCA} = V_{CCB} = 3.3 \text{ V}, V_I = 0 \text{ V or } V_{CCA/B}$	3.5	pF
C _{IN}	Input Pin Capacitance	$V_{CCA} = V_{CCB} = 3.3 \text{ V}, V_I = 0 \text{ V or } V_{CCA/B}$	5.0	pF
C _{OUT}	Output Pin Capacitance	V _{CCA} = V _{CCB} = 3.3 V, V _I = 0 V or V _{CCA/B}	5.0	pF
C _{PD}	Power Dissipation Capacitance	V _{CCA} = V _{CC2} = 3.3 V, V _I = 0 V or 3.3 V, f = 10 MHz	10	pF

^{1.} Typical values are at $T_A = +25$ °C.

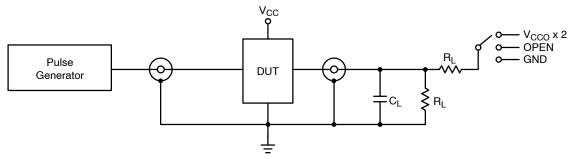


Figure 3. AC (Propagation Delay) Test Circuit

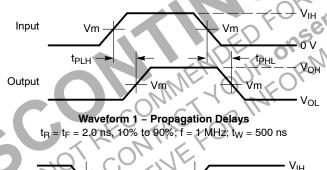
Test	Switch
t _{PLH} , t _{PHL}	OPEN
t _{PLZ} , t _{PZL}	V_{CCO} x 2 at V_{CCO} = 3.0 V – 3.6 V, 2.3 V – 2.7 V, 1.65 V – 1.95 V, 1.4 V – 1.6 V
t _{PHZ} , t _{PZH}	GND

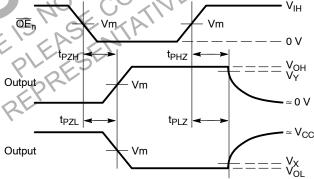
 C_L = 15 pF or equivalent (includes probe and jig capacitance)

 $R_L = 2 k\Omega$ or equivalent

 Z_{OUT} of pulse generator = 50 Ω

 $\ensuremath{V_{CCO}}$ is the supply voltage referenced to by the output being tested





Waveform 2 – Output Enable and Disable Times $t_R = t_F = 2.0 \text{ ns}, 10\% \text{ to } 90\%; f = 1 \text{ MHz}; t_W = 500 \text{ ns}$

Figure 4. AC (Propagation Delay) Test Circuit Waveforms

Symbol	Input Pin Output Pin
V _m	V _{CCX} /2
V _X	V _{OL} x 0.1
V _Y	V _{OH} x 0.9

UQFN12 1.7x2.0, 0.4P CASE 523AE-01 **ISSUE A**

DATE 11 JUN 2007



PIN 1 REFERENCE

0.10 C

0.10 C

0.05 С

0.05 C **TOP VIEW**

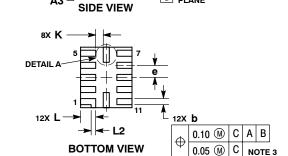
A1

2X |

12X 🗀



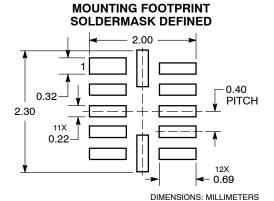




DETAIL B

SEATING PLANE

-A B



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM
- FROM TERMINAL TIP.

 MOLD FLASH ALLOWED ON TERMINALS

 ALONG EDGE OF PACKAGE. FLASH 0.03

 MAX ON BOTTOM SURFACE OF
- TERMINALS.
 DETAIL A SHOWS OPTIONAL
 CONSTRUCTION FOR TERMINALS.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.45	0.55		
A1	0.00	0.05		
A3	0.127	REF		
b	0.15	0.25		
D	1.70	BSC		
E	2.00	BSC		
е	0.40	BSC		
K	0.20			
L	0.45	0.55		
L1	0.00	0.03		
L2	0.15	REF		

GENERIC MARKING DIAGRAM*



XX = Specific Device Code

= Date Code

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

DOCUMENT NUMBER:	98AON23418D	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	UQFN12 1.7 X 2.0, 0.4P		PAGE 1 OF 1

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales